

Electro-optic modulation of solution-processed molybdenum disulfide

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Solution-processed molybdenum disulfide (MoS₂) shows promise for tunable photonics and optoelectronics development. However, though scalable, it often leads to devices with inferior performance as a result of its random, discrete nature. In this study, we show via density-functional-theory calculations that the electronic structure of the individual solution-processed nanosheets can be modulated collectively by external electric fields. Particularly, the nanosheets can form Stark ladders, giving variations in the underlying optical processes and thus tunable collective optical properties. We confirm this electro-optical modulation experimentally using solution-processed MoS₂ films with ferroelectric poly(vinylidene fluoride-co-trifluoroethylene) [P(VDF-TrFE)] incorporated, and prove that the local polarization fields from P(VDF-TrFE) can modulate the collective optical properties of the MoS₂, specifically, the optical absorption and photoluminescence. Given the scalability of solution processing, our results underpin the potential of electro-optical modulation of solution-processed MoS₂ for tunable photonics and optoelectronics development. To illustrate this potential, we demonstrate solution-processed electroabsorption modulators.

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I. INTRODUCTION

Tunable photonics and optoelectronics play a crucial role in sensing, communications, and manufacturing [1]. Mono- and few-layer molybdenum disulfide (MoS₂), with unique electronic structure transition and dynamical optoelectronic process, has attracted significant interest for photonics and optoelectronics innovations. Particularly, the quantum confinement and spontaneous broken translational symmetry enables modulation of the electronic structures and thus the optical processes for tunable

photonics and optoelectronics [2–5]. Though promising, large-scale crystalline MoS₂ production remains challenging for the device fabrication [6]. In contrast, solution-processing scales up the production and allows large-area depositions by printing and coating [7–9]. However, the solution-processed MoS₂ is in fact random, discrete networks of mono- and few-layer nanosheets [10, 11]—while the individual nanosheets retain the intrinsic materials physics and properties, the networks exhibit compromised collective properties with distinctly differentiated materials physics.

Understanding the underlying optical processes and properties of solution-processed MoS₂ is pivotal for developing its tunable photonics and optoelectronics. Given the discrete nature, the individual nanosheets can be

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regarded as independent systems, while the networks can be analyzed collectively from the perspective of statistical physics [12]. When subjected to external stimuli, such as light, the collective optical response, $I_{\text{collective}}$, is primarily determined by the structural parameters of the networks and the material physics of the individual nanosheets. Assuming a network comprising N nanosheets, wherein each nanosheet is characterized by M parameters, the collective optical response $I_{\text{collective}}$ can be described as

$$I_{\text{collective}} = \sum_i^N I_i = \sum_i^N I_i \left[\left(\prod_j^M \xi_{ij} \right) \cdot \varphi_i(C; \mathbf{s}_i) \right], \quad (1)$$

where ξ_{ij} is the element of the structural parameter matrix, $\Xi = [\xi_{ij}]_{N \times M}$, representing the j th structural parameter (e.g., the effective area and tilting angle) of the i th nanosheet. The optical response of the i th nanosheet, φ_i , is a function of the incident radiation, $\mathbf{s}_i$, and the modulation approach, C .

Previous studies report that the electronic structures in mono- and few-layer MoS₂ can be modulated by external fields (e.g., magnetic, thermal, and electric fields) [2]. Amongst them, the electric fields are a convenient modulation approach, in particular, for micro-nano device operations. In fact, considering the interplay between the electronic structure and optical transitions, the electric field effect on the optical properties of MoS₂ and the related two-dimensional (2D) materials has been an interesting topic. For example, theoretical [13–15] and experimental [16–20] studies have been made to explore tuning the exciton properties of transition metal dichalcogenides and their heterostructures by electric fields. Note that due to the small Bohr radius and large exciton-binding energy, the fields for dissociation of the strongly bound excitons can be substantial [21]. Besides, previous studies have proposed electric field effect tuning with dielectric engineering [13–15]. However, these studies are based on nanosheet and heterostructure samples prepared by mechanical exfoliation and chemical-vapor deposition. The optical property tuning revealed can thus be deviated from that of solution-processed MoS₂. Nevertheless, as the individual solution-processed nanosheets still maintain a two-dimensional quantum confined configuration, electric fields may still be a viable modulation approach for solution-processed MoS₂. Indeed, in our prior study [22], we show that the electronic structures and thus properties of liquid-phase exfoliated MoS₂ can vary in local electric fields via a quantum confined Stark effect (QCSE).

In this context, we understand that the optical properties of the individual solution-processed MoS₂ nanosheets may be modulated by electric fields; by accumulating the minute variations in the individual nanosheets, substantial changes may render collectively. Note that distinct from our prior study on electronic property modulation [22],

here we focus on electro-optical modulation of solution-processed MoS₂. Given the interplay between the electronic structure of matter and its optical properties, the findings in our prior study lay the foundation for us to understand the electro-optical modulation physics and mechanisms. We then explore the application of the electro-optical modulation mechanisms in developing tunable photonics and optoelectronics, for instance, fabricating solution-processed electroabsorption modulators based on MoS₂.

II. OPTICAL PROCESSES IN SOLUTION-PROCESSED MoS₂

Light-matter interactions in semiconductors typically involve reflection, absorption, and transmission (i.e., optical processes without energy conversion), and inelastic scattering of photons and photoluminescence (i.e., optical processes with energy conversion); Fig. 1(a). More explicitly, the transitions in solution-processed MoS₂ include band-to-band direct transition in direct band-gap monolayers [Fig. 1(b)], and phonon-assisted indirect transition in indirect band-gap few layers [Fig. 1(c)].

We study the light-matter interactions in solution-processed MoS₂ using density-functional-theory (DFT) calculations (see Appendix A). Figure S1 within the Supplemental Material [28] shows our calculated band-to-band direct transition in the direct band-gap monolayers that occurs between the conduction-band minimum (CBM) and valence-band maximum (VBM) at $K^\pm$. Specifically, the conduction- and valence-band edge states are primarily composed of the d_{z^2} states and $d_{x^2-y^2} \pm id_{xy}$ states of the molybdenum (Mo) atoms, respectively, both mixed with the $p_x \mp ip_y$ states of the sulfur (S) atoms (Fig. S2 within the Supplemental Material [28]). Meanwhile, as shown in Fig. S1 within the Supplemental Material [28], our calculations reveal that the phonon-assisted indirect transition in the indirect band-gap few-layers occurs between the CBM at the halfway point Λ_{min} of the $\Gamma - K$ path and VBM at Γ .

Given that solution-processed MoS₂ is usually four–five layers for the averaged thickness [23,24], we calculate and present in Fig. 1(d) the electronic structure from pentalayer as representative for solution-processed MoS₂. More explicitly, we present in Figs. 1(e)–1(g) the orbital weight of the Mo and S atoms as well as the density of states (DOS). As shown, the CBM at Λ_{min} is primarily composed of Mo: $d_{x^2-y^2} \pm id_{xy}$ states mixed with S: $p_x \mp ip_y$ orbitals, while the VBM at Γ is mainly contributed by Mo d_{z^2} states and S p_z orbitals.

III. FORMATION OF STARK LADDERS IN FEW LAYER MoS₂

When nanostructured materials are applied with an external electric field, F , their electronic structures can

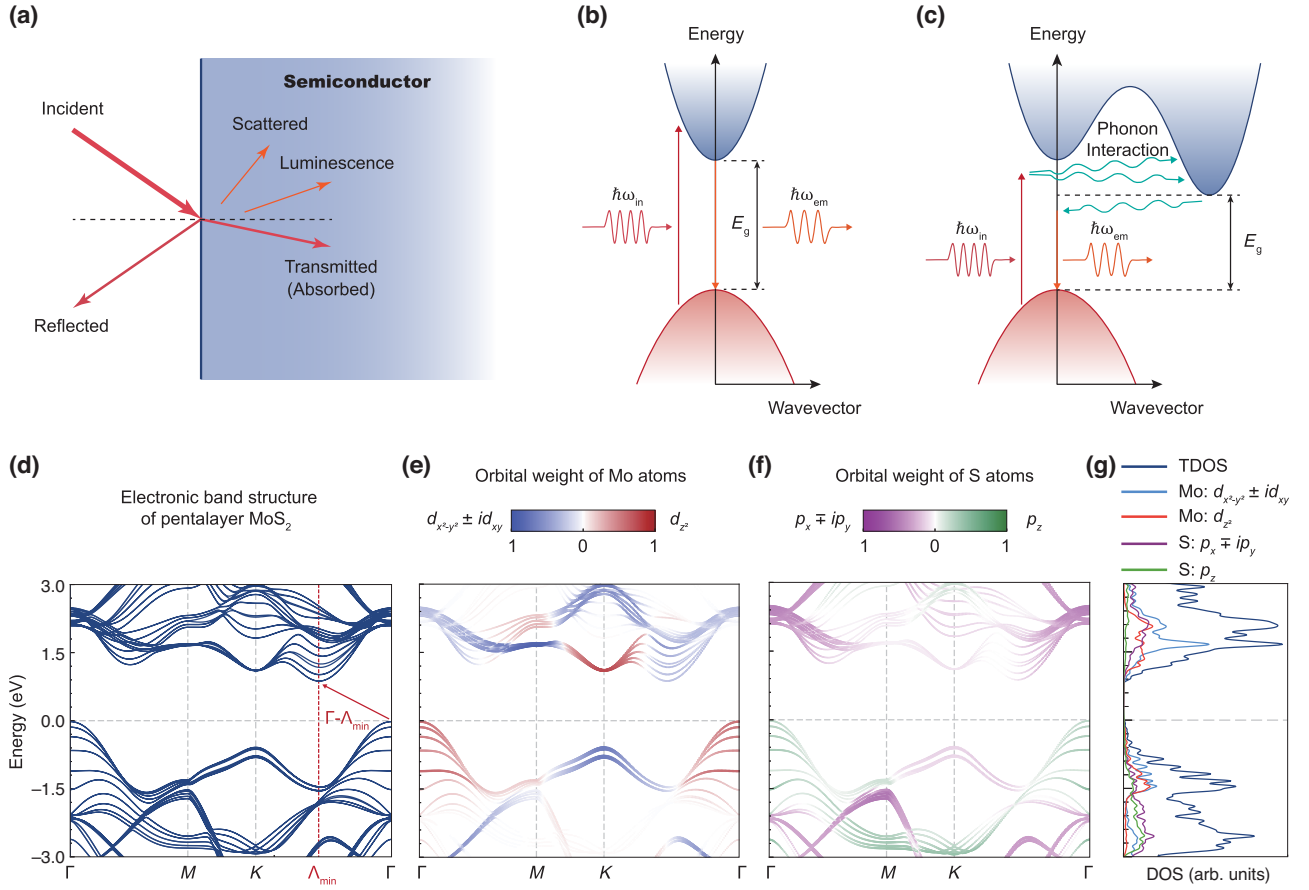


FIG. 1. Optical processes in solution-processed MoS₂. (a) Schematic linear and nonlinear light-semiconductor interactions. (b) Schematic band-to-band transition in direct band-gap semiconductors, and (c) phonon-assisted transition in indirect band-gap semiconductors. (d) Calculated electronic band structure for pentalayer MoS₂, and the orbital weight of the (e) Mo atoms and (f) S atoms, as well as (g) the density of states (DOS). The calculated results from pentalayer MoS₂ are presented as representative for solution-processed MoS₂. See Fig. S1 within the Supplemental Material for the results from the other layer numbers [28].

variate and give electronic band splitting and band-gap reduction, as governed by QCSE [25–27]. The electronic structure evolution due to QCSE exhibits dependence on the dimension of the nanostructured materials. Solution-processed MoS₂ with an averaged thickness of four–five layers can undergo intense QCSE.

Figure 2(a) schematically illustrates the electronic structure evolution in the few layers—when applied with an external electric field, the few layers with the intralayer spacing can form intralayer dipole moments; once the intralayer dipoles are formed, redistribution of the charges in response to the field can become significant and render intense QCSE. Indeed, intense QCSE is proved in our calculations, with the band-gap significantly narrowed in the few layers; Fig. 2(b). Notably, as shown in Fig. 2(c), the QCSE gets enhanced with the thickness of the few layers. In contrast, as the monolayers lack an intralayer spacing, the formation of effective intralayer dipoles is inhibited, leading to less profound QCSE in the monolayers [Fig. 2(c)].

Therefore, based on the above results and understanding, while the monolayers contribute to the optical properties of solution-processed MoS₂, the few layers primarily govern the optical response changes induced by the QCSE in the electric field, F , as described in Eq. (2):

$$I_{\text{collective}}(F) = I_{\text{monolayer}} + I_{\text{fewlayer}}(F), \quad (2)$$

where $I_{\text{collective}}$, $I_{\text{monolayer}}$ and I_{fewlayer} denote the collective optical response and that from the monolayers and few layers, while the optical response modulation approach is the electric field, F , that is applied to the solution-processed MoS₂. Focusing on the few layers, the electric field, F , can induce a progressive band splitting [Fig. 2(D)], where each of the atomic layers occupies the states at different energy levels (Fig. S3 within the Supplemental Material [28]). The progressive band splitting can eventually lead to the formation of steplike band structures, known as *Stark ladders* [Fig. 3(a)].

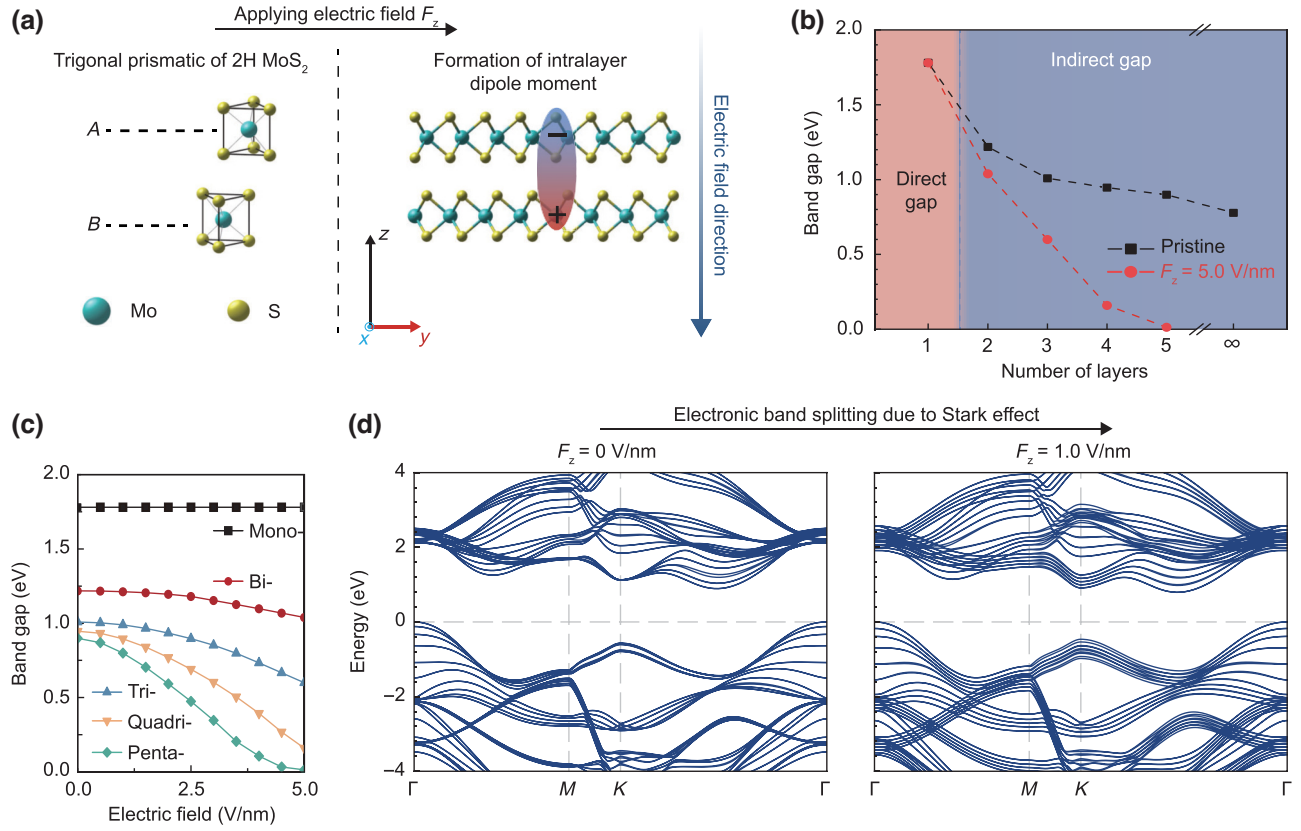


FIG. 2. Electronic structure evolution in solution-processed MoS₂ in external electric fields. (a) Schematic atomic structure of hexagonal (2H) MoS₂, and the formation of intralayer dipole moments in response to an electric field. (b) Calculated band-gap summary for pristine monolayer, few-layer, and bulk MoS₂ without and with an electric field of $F_z = 5.0$ V/nm. (c) Band-gap evolution in monolayer to pentalayer MoS₂ in a longitudinal electric field F_z . (d) Electronic band splitting in pentalayer MoS₂ due to QCSE incurred by the electric field.

Here we note that symmetry operation is excluded in our above DFT calculations. See Appendix B and Note S1 within the Supplemental Material [28] as well as Fig. S4 within the Supplemental Material [28] for our extended DFT calculations with symmetry operation. The symmetry operations in DFT calculations can variate the band-gap narrowing rates and thus, the critical fields to turn off the band-gap [29]. Since the electric field implicitly breaks the symmetry of the mono- and few-layer MoS₂, excluding symmetry in DFT calculations may give more reasonable results, as reported in prior studies [30]. Nevertheless, both energy band splitting and band-gap narrowing are proved in our calculations regardless of the symmetry operation, though large differences in the band splitting and band-gap narrowing rates are observed.

IV. ABSORPTION COEFFICIENT VARIATION AT THE ABSORPTION EDGES

The emergence of Stark ladders can significantly alter the optical processes in solution-processed few-layer MoS₂ nanosheets [31,32]. As such, electric fields and

the induced QCSE can potentially modulate the collective optical response of solution-processed MoS₂. Here we note that, without considering the excitonic effects, QCSE can be considered as extreme quantization of the Franz-Keldysh effect in thin-slab structured materials [33]. Therefore, the optical absorption coefficient of solution-processed few layers for photons with energy less than the band-gap, E_g , can be expressed by Eq. (3) [34,35]:

$$\alpha(\omega, F_z) = \frac{1}{2} \alpha(\omega, 0) \exp \left[-\frac{4}{3} \left(\frac{E_g - \hbar\omega}{\hbar\theta_z} \right)^{3/2} \right], \quad (3)$$

where $\alpha(\omega, 0)$ is the initial optical absorption coefficient in the absence of the electric fields, and $\hbar\theta_z = (e^2 F_z^2 \hbar^2 / 2\mu_z)^{1/3}$ is a function of the longitudinal electric fields F_z (see Note S2 within the Supplemental Material [28]). The progressive band splitting and Stark-ladder formation in the few layers can result in a red shift of the collective optical absorption edges, as schematically illustrated in Fig. 3(b). According to Eq. (3), the red shift

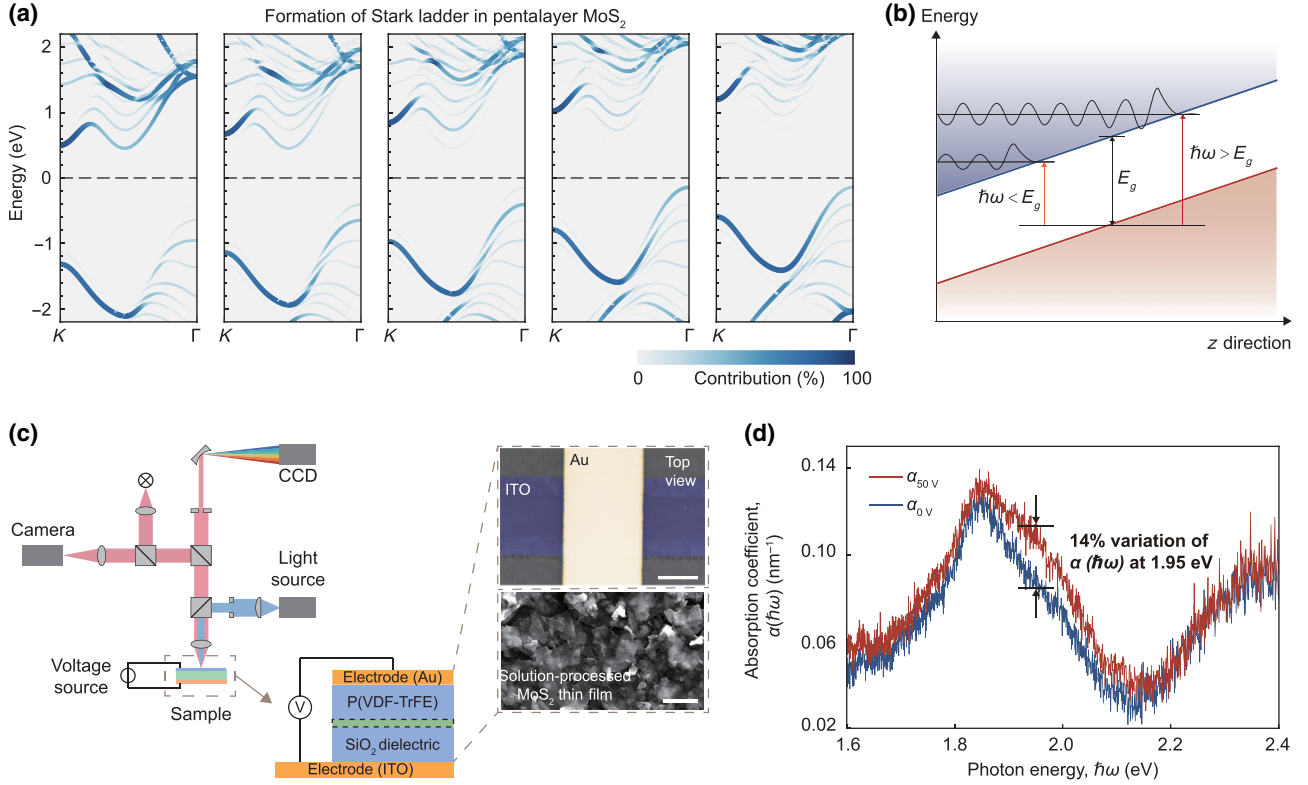


FIG. 3. Electro-optical modulation of solution-processed MoS₂. (a) The formation of Stark ladders in pentalayer MoS₂. (b) Schematic Franz-Keldysh effect due to the Stark ladders in response to the electro-optical modulation. (c) Schematic setup for *in situ* electro-optical characterization of solution-processed MoS₂. The subplots to the right show a detailed sketch illustrating the *in situ* characterization, and a top-view optical microscopic image of a typical solution-processed MoS₂ film for the characterization, as well as a scanning microscopic image showing the deposition of the MoS₂ nanosheets. The green layer as marked corresponds to the deposited solution-processed MoS₂ layer. Scale bars: (top) 500 μm , (bottom) 500 nm. Note a scanning microscopic image of a larger scale is shown in Fig. S9 within the Supplemental Material [28]. (d) Optical absorption coefficient spectrum of the solution-processed MoS₂ film with and without bias.

can lead to changes in the intensity of the optical absorption and reflection for incident light with wavelength $\lambda > hc/E_g$ ($h = 2\pi\hbar$ is the Planck constant, and c is the speed of light), and the most significant changes occur at the initial optical absorption edges.

To experimentally validate our findings, we design a setup [Fig. 3(c)] for *in situ* electro-optical characterizing solution-processed MoS₂ (see Appendix D). Here we prepare MoS₂ via electrochemical exfoliation (see Appendix C). Electrochemical exfoliation can yield large and thin nanosheets [23,24,36], facilitating uniform depositions over large areas, favorable for optical characterizations and device fabrications. Material characterizations confirm that the exfoliated MoS₂ is in the pristine 2H phase (Fig. S5 within the Supplemental Material [28]). Statistical atomic force microscopy (AFM) characterization shows that the averaged thickness of the exfoliated MoS₂ is 3.57 nm (about four–five layers, in alignment with our DFT calculations), and the averaged lateral dimension is 606.6 nm; Fig. S6 within the Supplemental Material [28]. The exfoliated MoS₂ is used to prepare films in a

structure of ITO/SiO₂/MoS₂/P(VDF-TrFE)/Au for convenient *in situ* electro-optical characterization, as shown by the subplots in Fig. 3(c). The ferroelectric P(VDF-TrFE) is incorporated to introduce the local polarization fields for inducing QCSE [37], while the SiO₂ is evaporated to prevent current leakages. Note that layer-by-layer spin coating and annealing are used for depositing the MoS₂ and P(VDF-TrFE), so as to avoid interlayer wetting and diffusion during deposition [22].

Using the *in situ* electro-optical characterization setup, we investigate field-induced modulation of the collective optical properties of solution-processed MoS₂. Indeed, as revealed in Fig. 3(d), the collective optical absorption coefficient from a typical solution-processed MoS₂ film varies in response to the bias applied. Notably, for the photons with energy less than 2.1 eV, the film exhibits an increased absorption. The maximum change (i.e., approximately 14 % variation) in the absorption coefficient occurs at approximately 1.95 eV, which is between the *A* (approximately 1.84 eV) and *B* (approximately 2.00 eV) excitonic absorption peaks of MoS₂. Therefore, the experimental

results validate our theoretical findings that the collective optical properties of solution-processed MoS₂ can vary at the absorption edges due to QCSE.

V. ELECTRIC-FIELD-INDUCED PHOTOLUMINESCENCE QUENCHING

The optical processes discussed so far do not involve energy conversion, such as photon-electron, photon-phonon, and photon-phonon-electron interactions. However, the QCSE-induced electronic structure evolution in solution-processed MoS₂ can also impact the energy-conversion processes. Here we investigate the photoluminescence emission as a demonstration. Unlike optical absorption, photon emission in MoS₂ typically occurs through the relaxation of the excited electrons and holes, followed by their recombination and subsequent photon emission [38,39]. The excited electron-hole pairs, however, tend to separate driven by the electric fields applied, as schematically illustrated in Figs. 4(a) and 4(b). As a result, the photon emission, measured as the photoluminescence intensity from the solution-processed MoS₂ films, can be decreased by the applied bias.

The decrease of the photoluminescence intensity, i.e., photoluminescence quenching, has been well studied in nanostructures [40,41], including 2D materials and their heterostructures [42]. Notably, these studies use straightforward models based on wave-function overlap to describe the electronic band-structure evolution in external fields. Compared to these systems, solution-processed 2D materials are essentially disordered, discrete percolative networks, and yet maintain a crystalline structure on the microscopic scale. Given this, a straightforward model based on wave-function overlap may not reveal the profound interactions between the solution-processed 2D material nanosheets. To understand photoluminescence quenching in solution-processed MoS₂, the individual nanosheets can be regarded as independent systems and described by straightforward models, while the networks can be analyzed collectively from the perspective of statistical physics. In this consideration, we will first need to understand the QCSE-induced electro-optical processes in the solution-processed MoS₂ nanosheets.

As discussed, the QCSE induced electro-optical processes in solution-processed MoS₂ are primarily governed by the indirect-band-gap few layers. Here we note that,

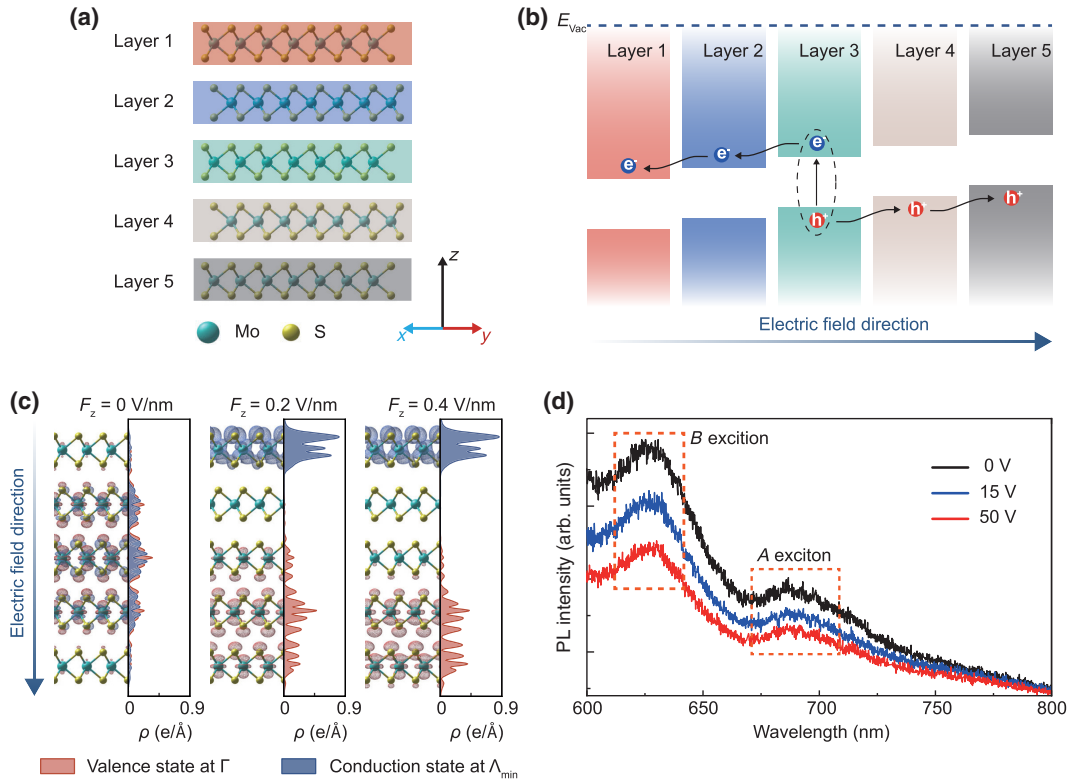


FIG. 4. Field-induced photoluminescence quenching in solution-processed MoS₂. (a) Structure of pentalayer MoS₂. (b) Schematic electron-hole pair separation in a MoS₂ nanosheet due to the Stark ladder in an external electric field, showing the separation and propagation of an electron-hole pair. (c) The calculated spatial distribution of the valence and conduction states in pentalayer MoS₂. Substantial spatial separation takes place in response to the external electric field, showing the redistribution of electrons and holes. (d) *In situ* experimental photoluminescence spectrum of the solution-processed MoS₂ film, showing electro-optical photoluminescence quenching.

coexisting with the phonon-assisted indirect transitions, direct transitions are not forbidden in the few layers [43,44]. Particularly, since the indirect transitions involve phonons, the probability is limited [35]. On the other hand, though the direct K – K transition is weakened due to the direct to indirect transformation from mono- to few layer, the probability can still be significant and dominate the photoluminescence process [43]. Given this, we focus on the direct transition. See Note S3 within the Supplemental Material [28] for discussion on the indirect transition involving the interaction of phonons.

In direct transition, the excitonic recombination probability per unit time in individual MoS₂ nanosheets can be expressed as [35]

$$\gamma_{c \rightarrow v} = \frac{2\pi}{\hbar} \cdot \left(\frac{eA_0}{m} \right)^2 \sum_{\mathbf{k}_c, \mathbf{k}_v} |P_{cv,\parallel} \cdot S_{cv,\perp}|^2 \times \sum_q |\phi_q(0)|^2 \delta[(E_g + E_q) - \hbar\omega], \quad (4)$$

where A_0 is the emission intensity, $\phi_q(0)$ is the wave function of the exciton with zero relative motion, E_q is the energy of the exciton, and $P_{cv,\parallel}$ is the transition dipole moment of the carrier recombination process. As the translational symmetry in the z direction is broken, the periodical interaction is limited to the two-dimensional atomic plane (xOy plane). And, the optical transition in the z direction is decided by the overlap integral between conduction and valence states, $S_{cv,\perp}$, as described by Eq. (5):

$$S_{cv,\perp} = \int_{L_z} \phi_c^* \phi_v dz = \int_{L_z} \phi_c \phi_v dz, \quad (5)$$

where ϕ_c and ϕ_v are the wave functions of conduction and valence states, respectively, and L_z is the thickness of the nanosheets. Similarly, this is also true for the phonon-assisted indirect transition (Note S3 within the Supplemental Material [28]). Therefore, as revealed by our calculations [Fig. 4(c)], in the presence of an external electric field, the wave functions of conduction and valence states spatially separate, leading to the reduction in the overlap integral $S_{cv,\perp}$. As such, the corresponding excitonic recombination probability per unit time in the few-layer MoS₂ nanosheets decreases. As discussed, the minute decrease can accumulate and quench the collective photoluminescence. See Note S4 within the Supplemental Material [28] for more detailed discussion.

To validate photoluminescence quenching in solution-processed MoS₂, we perform *in situ* photoluminescence characterization. As shown in Fig. 4(d), the photoluminescence intensity decreases as the bias increases. Specifically, as observed, the two characteristic photoluminescence peaks corresponding to the emission of the *A* (approximately 1.80 eV) and *B* (approximately 1.98 eV)

excitons in MoS₂ exhibit significant decreases. Note that the measured full width at half maximum of the photoluminescence peaks (approximately 70 nm) is considerably broader than those reported for the mono- and few-layer crystalline MoS₂ nanosheets [45]. This broadening is attributed to the mixture of nanosheets with various thicknesses in the solution-processed MoS₂. Besides, previous studies report that the photoluminescence from few-layer MoS₂ may red shift due to the Stark effect [25,30]. However, no obvious red shifting is observed during quenching in our characterization. As discussed, the monolayers primarily dominate the photoluminescence of the solution-processed MoS₂, and as the monolayers do not undergo significant Stark effect and band-gap reduction [Figs. 2(b) and 2(c)], the overall photoluminescence does not render notable red shifting. However, as observed, the photoluminescence peaks are broadened during quenching, suggesting the photoluminescence from the few layers may have red shifted. To study this further, we perform multipeak fitting [46] of the photoluminescence spectra (Fig. S7 within the Supplemental Material [28]), and the two emerging red-shifted wave packets suggest a red-shifting photoluminescence from the few layers. Therefore, we understand that the photoluminescence from the few layers do red shift during quenching, but the red shifting is overshadowed by the relatively intense photoluminescence from the monolayers. Nevertheless, the *in situ* electrophotoluminescence characterization confirms the photoluminescence quenching and proves that electric fields can be employed to effectively modulate the collective energy-conversion optical processes in solution-processed MoS₂.

VI. SOLUTION-PROCESSED ELECTROABSORPTION MODULATORS

An effective electro-optical modulation of solution-processed MoS₂ holds the potential for tunable optical device development. To illustrate this potential, as an example, we fabricate electroabsorption modulators (EAMs). Capable of actively modulating the optical fields with bias, EAMs are an indispensable technology for datacom and optical computing [47,48]. However, current EAMs demand high-precision manufacturing of highly crystalline optical materials, such as silicon, lithium niobate, and III-V semiconductors. This leads to the high cost of the EAMs, a stringent barrier for the widespread applications of EAMs [49,50]. Continuous efforts have been made to explore alternative optical materials and fabrication methods for scaled-up, more accessible EAMs.

Optimizing our solution-processed MoS₂ film development, we fabricate the EAMs, as shown in Fig. 5(a) (see also Fig. S8 within the Supplemental Material [28]). As observed in Figs. 5(b)–5(d), after optimization, the EAMs develop distinct layer-by-layer interfaces. Upon

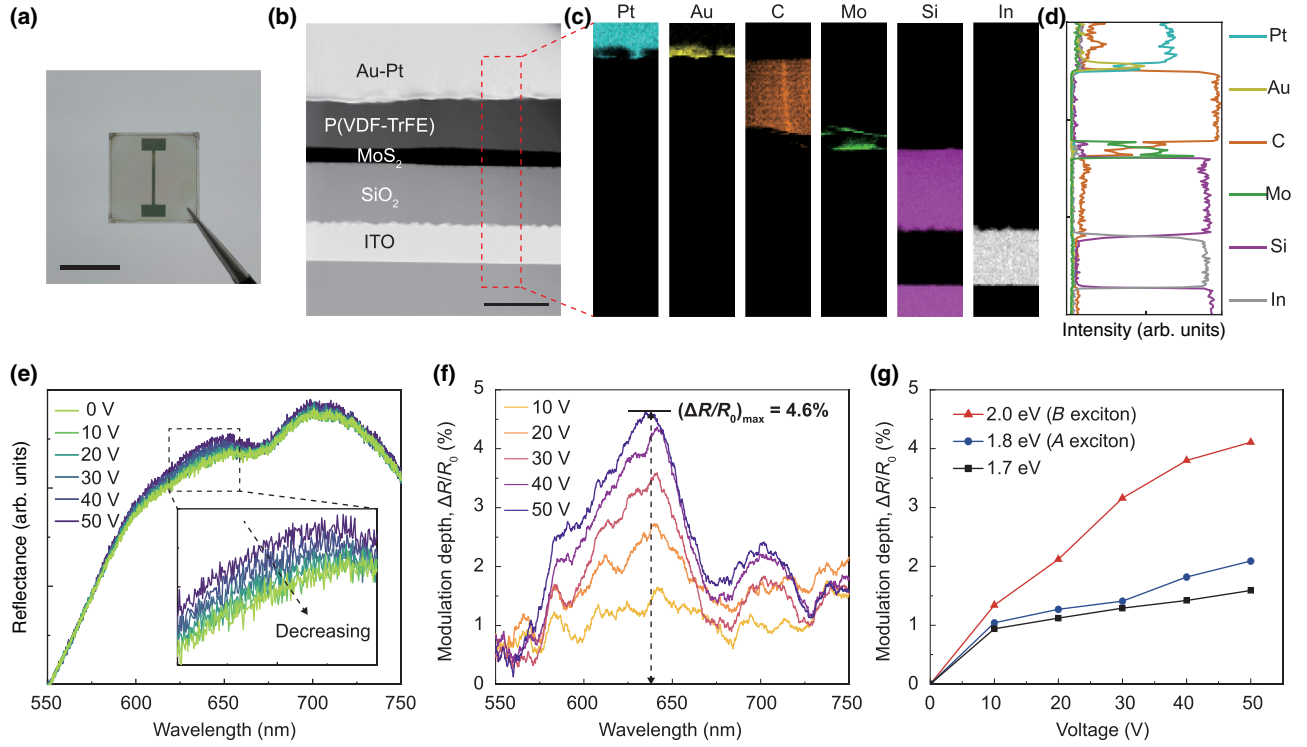


FIG. 5. Solution-processed MoS₂ electroabsorption modulators (EAMs). (a) Photo of a typical device. (b) Cross-section scanning transmission electron microscopic image of the device, and the corresponding (c) energy-dispersive x-ray area mapping and (d) linear profile. The device is in an ITO/SiO₂/MoS₂/P(VDF-TrFE)/Au structure. (e) *In situ* electroreflectance spectrum of the device under the different biases, and (f) the corresponding static absorption modulation depth $\Delta R/R_0$ calculated from the *in situ* electroreflectance. (g) Summary of the modulation depth of the device to the characteristic photon energies, i.e., the *A*, *B* excitons and an energy slightly smaller than the absorption edge of the solution-processed MoS₂. Scale bars: (a) 10 mm, (b) 500 nm.

in situ electro-optical characterization, we select reflective mode as the back electrode of gold is opaque to visible light. This gives the EAMs a zero transmissivity ($T = 0$), while the transparent front electrode of ITO and insulating layer of SiO₂ allow measurement of the reflection from the MoS₂ sandwiched in the EAMs. Neglecting the minimal optical absorption by ITO and SiO₂, the optical reflectivity (R) and absorptivity (A) of the MoS₂ give $R + A = 1$. Consequently, the change in the absorption by the MoS₂ can be interpreted as the change in the reflection using Eq. (6):

$$\begin{aligned} \Delta I_{\text{reflected}}(V, \lambda) &= I_{\text{reflected}}(V, \lambda) - I_{\text{reflected}}(0, \lambda) \\ &= -\Delta I_{\text{absorbed}}(V, \lambda), \end{aligned} \quad (6)$$

where $I_{\text{reflected}}$ denotes the measured intensity of the reflection with wavelength λ , and ΔI represents the intensity changes in optical absorption and reflection.

As shown in Fig. 5(e), the reflectance of a typical MoS₂ EAM decreases in response to the applied bias. This is consistent with the predicted rise in the absorption coefficient according to our calculations above. More explicitly, as shown in Fig. 5(f), the spectrum of the static modulation depth ($\Delta R/R_0$) as calculated from Fig. 5(e) indicates

that the EAM exhibits a reflection modulation for the incident light with wavelength > 575 nm (corresponding to a photon energy around and below the characteristic *A* and *B* excitons). Further, as observed, the modulation strength is most pronounced at the absorption edges (near the *A* and *B* exciton locations), and it increases with the applied bias, as shown in Fig. 5(g). Note that the maximal modulation depth of the EAM is about 4.6 % at approximately 638 nm, corresponding to the maximum change in the absorption coefficient at 1.95 eV [Fig. 5(f)]. As such, the maximal extinction ratio of the EAM can be estimated as $(R_{\text{on/off}})_{\text{max}} = 4.343 \times [\alpha_{50\text{V}}(1.95 \text{ eV}) - \alpha_{0\text{V}}(1.95 \text{ eV})] \times L$, where L is the thickness of the MoS₂ film (approximately 100 nm). The estimation yields an extinction ratio of approximately 8.25 dB. The relative static modulation efficiency, $(R_{\text{on/off}})_{\text{max}}/\Delta V$, is thus estimated as approximately 0.165 dB/V.

While proving the functionality of EAMs, our solution-processed MoS₂ EAMs with the exhibited optical modulation performance are not yet comparable to state-of-the-art reports [51,52]. Much work is needed to improve the modulation depth, the extinction ratio, and the modulation efficiency via advancements in materials processing and device fabrication as well as metasurface designs [53].

Nevertheless, our EAMs prove the feasibility of electro-optical modulation of solution-processed MoS₂ for scaled-up tunable photonics and optoelectronics.

VII. CONCLUSION

We have demonstrated electro-optical modulation of solution-processed MoS₂. Through extensive DFT calculations, we have revealed that the optical properties of solution-processed MoS₂ can undergo collective changes when subjected to electric fields. The changes are attributed to the collective evolution of the underlying electronic structure in the randomly networked nanosheets. This electro-optical modulation is experimentally confirmed, where we prove solution-processed MoS₂ exhibits notable electric-field-induced modulation of the optical absorption and photoluminescence. Employing this electro-optical modulation approach, we have demonstrated EAMs, as an example to illustrate the potential for developing tunable photonics and optoelectronics from solution-processed MoS₂. The prototyped EAMs exhibit a static modulation depth of 4.6 %, an extinction ratio of 8.25 dB, and a static modulation efficiency of 0.165 dB/V. Though further improvements in materials processing and device fabrication as well as metasurface designs are required to enhance the optical modulation performance, this demonstration has proved the feasibility of developing solution-processed tunable photonics and optoelectronics of MoS₂.

Here we would like to note that the DFT calculations in our study assume the MoS₂ nanosheets are placed in vacuum (see Appendix B). However, the dielectric environment can seriously impact the electro-optical modulation of the MoS₂ nanosheets [54–56], for example, dielectric screening and weakening of the effect of external electric fields [57]. Besides the electric-field-induced QCSE, the electro-optical modulation may partially originate from the moving charges from the surrounding insulators as driven by the electric fields [58]. Regarding the PL quenching observed, besides the electro-optical modulation, doping-induced trions in the solution-processed MoS₂ nanosheets may be a possible mechanism. Doping induced trions can broaden and redshift the neutral exciton emission [59,60]. However, deeper insights into the dielectric environment, the moving charges from the surrounding insulators, and the doping-induced trions require further detailed investigations. Nevertheless, a deeper insight will be key to the further optimization of the electro-optical modulation and to promote the performance of the solution-processed electro-optic modulators towards practical applications.

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APPENDIX A: DENSITY-FUNCTIONAL-THEORY CALCULATIONS

Vienna *ab initio* simulation package (VASP) [61] is adopted to perform the density-functional-theory calculations. Projector augmented-wave pseudopotential [62] is used to describe the interaction between the ionic core and valence electrons. The generalized gradient approximation functional in the Perdew-Burke-Ernzerhof scheme [63] is used to describe the exchange-correlation (XC) energy between the electrons. The Mo (*4p*, *5s*, *dd*) states and S (*s*, *p*) states are treated as valence states. The plane-wave cutoff energy is set to be 500 eV. van der Waals correction is carried out during the crystal structural relaxation using the DFT-D3(BJ) method [64,65]. The structure of all the systems is fully optimized until the residual force on the atoms is less than 0.01 eV/Å. For the broken translational symmetry in the solution-processed MoS₂ nanosheets, we use a slab geometry with a 22-Å vacuum layer to prevent the interaction between the nanosheets. For the self-consistent iteration, the convergence tolerance between the successive steps is set as 1×10^{-6} eV. The Monkhorst-Pack method is used to generate the *k*-point grid. All the solution-processed MoS₂ nanosheets use a $14 \times 14 \times 1$, $21 \times 21 \times 1$, and $31 \times 31 \times 1$ grid for the structural relaxation, self-consistent calculation, and calculation of density of states, respectively. The visualization of the atomic structure, molecular orbitals, and charge density are carried out via VESTA [66].

APPENDIX B: SIMULATION OF THE STARK EFFECT

In the simulation of the Stark effect in solution-processed MoS₂, the electric field is applied by introducing dipole sheet within the vacuum layer. Considering that the electric field applied to the solution-processed MoS₂

is mediated by the dipole polarization of the insulating SiO₂ and ferroelectric P(VDF-TrFE) layer, setting a dipole sheet as electric field source is reasonable. Note that, although the composition of the solution-processed MoS₂ is random, the orientation of the nanosheets within is ordered to some extent in a microscopic scale. As demonstrated in Fig. S6 within the Supplemental Material [28], the averaged lateral dimension of the MoS₂ nanosheets is about 170 times of their averaged thickness. Vertical alignment of the nanosheets is highly unstable. Indeed, the nanosheets are largely placed horizontally while randomly connect with the neighboring nanosheets, as demonstrated in Fig. 3(c) (see also Fig. S9 within the Supplemental Material [28]), where the top-view scanning electron microscopic image show ordered orientation of the nanosheets in a microscopic scale. Therefore, a vertically applied electric field is suitable for the calculations and can give an effective explanation to the results observed.

During calculation of the charge density under the external electric fields, note that the symmetry operation can play a significant role. To figure out its relevance, in Fig. S4 within the Supplemental Material [28], we examine the impact of symmetry operation on the electric field effect on bilayer MoS₂ nanosheets, with or without considering the spin-orbit coupling (SOC). The effect of SOC on the Stark effect of bilayer MoS₂ is negligible, while symmetry can lead to major differences. This may originate from the symmetry confinement that traps the electronic structure of the system inside a local minimum, leading to an inappropriate charge density configuration.

In a general DFT calculation protocol, including symmetry operation is set as default in VASP (ISYM = 2) [67]. Under this setup, VASP firstly determines the symmetry characteristic (space group) based on the configuration of the target system, and uses the symmetry operators of the corresponding space group to directly symmetrize the target charge density. As such, VASP can reduce the computation load. In the case of mono- and few-layer MoS₂, odd number of layers MoS₂ has space group $P\bar{6}m2$ belonging to point group D_{3h} , while even number of layers MoS₂ has space group $P\bar{3}m1$ belonging to point D_{3d} [68,69]. Point group D_{3h} has a horizontal mirror operator σ_h , and point group D_{3d} has an inversion center i [68,69]. In normal cases, when the symmetry operation is on, these two operators reflect the charge density along the z direction across the horizontal plane located at the middle of the unit cell specularly and inversely, respectively. Instead of directly calculating the charge density of the whole structure, this simplification by symmetry operation is more effective.

However, the introduction of the vertical electric field can surely break the mirror and inversion symmetries. Although the calculation results of including symmetry operation (Fig. S4 within the Supplemental Material [28]) is consistent with previous theoretical studies [26,70],

the results of excluding symmetry operation (Fig. 2; Fig. S4A, D–I within the Supplemental Material [28]) is closer to the experimental reports [30]. As such, deactivating symmetry operation (ISYM = −1/0) is adopted in our study and presented in the main context. The choice of symmetrizing the k -point mesh instead of directly symmetrizing the charge density may also work, but this is not investigated in our research. It is observed that although the band-gap reduction rate, i.e., the linear Stark effect coefficient, is deviated from that reported in previous studies [26,70], the evolution of the electronic structure redistribution and the resultant band splitting alongside band-gap reduction in response to the electric fields in the few-layer MoS₂ is confirmed and consistent.

APPENDIX C: SOLUTION-PROCESSING AND DEVICE FABRICATION

Solution-processed MoS₂ suspension is prepared by electrochemical exfoliation of bulk MoS₂ crystals (SPI Supplies) for spin-coating deposition. The electrochemical exfoliation process follows the method reported in Ref. [24]. P(VDF-TrFE) (70:30) (Sigma) is dissolved in methyl ethyl ketone (MEK) (Sigma) via magnetic stirring to form a 60 mg/ml solution for spin coating (Fig. S10 within the Supplemental Material [28]). SiO₂ is deposited onto the ITO substrate via e -beam evaporation. The solution-processed MoS₂ suspension and P(VDF-TrFE) dispersion are then deposited onto the ITO/SiO₂ substrate through a layer-by-layer spin-coating process, followed by a heat treatment to remove the residual solvents. Opaque back-contact Au electrode is deposited through e -beam evaporation on the top to complete the device fabrication.

APPENDIX D: *IN SITU* ELECTRO-OPTICAL CHARACTERIZATIONS

The *in situ* electro-optical characterizations are performed at room temperature using a 532-nm continuous laser excitation with a diffraction-limited excitation beam diameter of 1 μ m. The excitation light is filtered by a 532-nm-long pass filter (Semrock). The photoluminescence signal light is separated by a 300 g/mm grating, and then received by a liquid nitrogen-cooled charge-coupled device. The *in situ* electro-optical characterizations under bias are implemented by Keithley 2636B.

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